## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination RAVERDY ET AL. Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0088980	04-2005	Olkkonen et al.	370/255
*	В	US-6,665,269	12-2003	Schmitz, Peter O.	370/251
*	C	US-2004/0218548	11-2004	Kennedy et al.	370/254
*	D	US-2003/0151513	08-2003	Herrmann et al.	340/573.1
*	E	US-2004/0174829	09-2004	Ayyagari, Deepak V	370/254
*	F	US-6,826,165	11-2004	Meier et al.	370/338
	G	US-			
	Н	US-			
	ı	US-			
	ť	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	: Classification
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## NON-PATENT DOCUMENTS

	NON-PATENT DOCUMENTS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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•	X.					

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